

SLLS657C-APRIL 2005-REVISED FEBRUARY 2009

DB, DW, OR PW PACKAGE

# 3-V TO 5.5-V MULTICHANNEL RS-232 LINE DRIVER/RECEIVER WITH ±15-kV IEC ESD PROTECTION

## FEATURES

- Single-Chip and Single-Supply Interface for IBM<sup>™</sup> PC/AT<sup>™</sup> Serial Port
- ESD Protection for RS-232 Bus Pins
  - ±15-kV Human-Body Model (HBM)
  - ±8-kV IEC61000-4-2, Contact Discharge
  - ±15-kV IEC61000-4-2, Air-Gap Discharge
- Meets or Exceeds Requirements of TIA/EIA-232-F and ITU v.28 Standards
- Operates With 3-V to 5.5-V V<sub>CC</sub> Supply
- Always-Active Noninverting Receiver Output . (ROUT2B)
- · Designed to Transmit at a Data Rate up to 500 kbit/s
- Low Standby Current . . . 1 µA Typ .
- External Capacitors . . . 4 × 0.1 µF •
- Accepts 5-V Logic Input With 3.3-V Supply •
- **Designed to Be Interchangeable With Maxim MAX3243E**
- Serial-Mouse Driveability
- Auto-Powerdown Feature to Disable Driver **Outputs When No Valid RS-232 Signal Is** Sensed
- Package Options Include Plastic Small-Outline • (DW), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages

## APPLICATIONS

- **Battery-Powered Systems** .
- PDAs
- **Notebooks**
- Laptops
- Palmtop PCs
- **Hand-Held Equipment**

	(TOP V		
	C2+[1	28] C1+	
	C2-[]2	27 🛛 V+	
	V- <b>[</b> ]3	26 🛛 V <sub>CC</sub>	
	RIN1 4	25 🛛 GND	
	RIN2	24 C1-	
	RIN3[6	23 FORCE	
	RIN4	22 FORCE	
		21 INVALID	
			3
		19 ROUT1	
		18 ROUT2	
	DIN3 12 DIN2 13	17 ROUT3 16 ROUT4	
	ы	6	
		15 ROUT5	
	QFN PAC (TOP V		
	NC - NC - C2- C2- C2-	NC C1+ NC CC	
	32 31 30 29	28 27 26 25	
RIN1 🗋 1			24 GND
RIN2 2			23 C1-
RIN3 3			22 FORCEON
			21 FORCEOFF
			19 ROUTB2
			18 ROUT1
DOUT3 D 8			17 CROUT2
	9 10 11 12	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	
	<u>z</u> z z c	115 114 NC	
	NC DIN3 DIN2 DIN1	ROUT ROUT ROUT N	



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## DESCRIPTION

The MAX3243E device consists of three line drivers, five line receivers, and a dual charge-pump circuit with  $\pm$ 15-kV ESD (HBM and IEC61000-4-2, Air-Gap Discharge) and  $\pm$ 8-kV ESD (IEC61000-4-2, Contact Discharge) protection on serial-port connection pins. The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. This combination of drivers and receivers matches that needed for the typical serial port used in an IBM PC/AT, or compatible. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. In addition, the device includes an always-active noninverting output (ROUT2B), which allows applications using the ring indicator to transmit data while the device is powered down. The device operates at data signaling rates up to 250 kbit/s and a maximum of 30-V/µs driver output slew rate.

Flexible control options for power management are available when the serial port is inactive. The auto-powerdown feature functions when FORCEON is low and FORCEOFF is high. During this mode of operation, if the device does not sense a valid RS-232 signal, the driver outputs are disabled. If FORCEOFF is set low, both drivers and receivers (except ROUT2B) are shut off, and the supply current is reduced to 1  $\mu$ A. Disconnecting the serial port or turning off the peripheral drivers causes the auto-powerdown condition to occur.

Auto-powerdown can be disabled when FORCEON and FORCEOFF are high, and should be done when driving a serial mouse. With auto-power<u>down enabled</u>, the device is activated automatically when a valid signal is applied to any receiver input. The INVALID output is used to notify the user if an RS-232 signal is present at any receiver input. INVALID is high (valid data) if any receiver input voltage is greater than 2.7 V or less than -2.7 V or has been between -0.3 V and 0.3 V for less than 30  $\mu$ s. INVALID is low (invalid data) if all receiver input voltages are between -0.3 V and 0.3 V for more than 30  $\mu$ s. Refer to Figure 5 for receiver input levels.

The MAX3243EC is characterized for operation from 0°C to 70°C. The MAX3243EI is characterized for operation from –40°C to 85°C.

T <sub>A</sub>	PA	CKAGE <sup>(1)(2)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	SOIC – DW	Tons and mal	MAX3243ECDW	MAX2042EC
	SOIC - DW	Tape and reel	MAX3243ECDWR	MAX3243EC
	SSOP – DB	Tono and roal	MAX3243ECDB	
0°C to 70°C	330P - DB	Tape and reel	MAX3243ECDBR	MAX3243EC
	TSSOP – PW	Tone and real	MAX3243ECPW	
	TSSOP – PW Tape and reel		MAX3243ECPWR	MP243EC
	QFN – RHB	Tape and reel	MAX3243ECRHBR	MP243E
	SSOP – DB	Tone and real	MAX3243EIDB	
	330P - DB	Tape and reel	MAX3243EIDBR	— MAX3243EI
	SOIC - DW	Tone and real	MAX3243EIDW	MAX3243EI
–40°C to 85°C	50IC - DW	Tape and reel	MAX3243EIDWR	
	TSSOP – PW	Tono and roal	MAX3243EIPW	
	1330P - PW	Tape and reel	MAX3243EIPWR	- MP243EI
	QFN – RHB	Tape and reel	MAX3243EIRHBR	MR243E

#### ORDERING INFORMATION

(1) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

(2) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.



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## **FUNCTION TABLES**

## EACH DRIVER<sup>(1)</sup>

		INPUTS		OUTPUT	
DIN	FORCEON	FORCEOFF	VALID RIN RS-232 LEVEL	DOUT	DRIVER STATUS
Х	Х	L	Х	Z	Powered off
L	Н	Н	Х	Н	Normal operation with
Н	Н	Н	Х	L	auto-powerdown disabled
L	L	Н	Yes	Н	Normal operation with
Н	L	Н	Yes	L	auto-powerdown enabled
L	L	Н	No	Z	Powered off by
н	L	Н	No	Z	auto-powerdown feature

(1) H = high level, L = low level, X = irrelevant, Z = high impedance

#### EACH RECEIVER<sup>(1)</sup>

	INP	UTS		OUTI	PUTS		
RIN2	RIN1, RIN3–RIN5	FORCEOFF	VALID RIN RS-232 LEVEL	ROUT2B	ROUT2	ROUT1, ROUT3–5	RECEIVER STATUS
L	Х	L	Х	L	Z	Z	Powered off while
Н	х	L	х	н	Z	Z	ROUT2B is active
L	L	н	YES	L	Н	Н	
L	Н	н	YES	L	L	L	Normal operation with
Н	L	н	YES	Н	Н	Н	auto-powerdown
Н	н	н	YES	Н	L	L	disabled/enabled
Open	Open	н	YES	L	Н	Н	

(1) H = high level, L = low level, X = irrelevant, Z = high impedance (off), Open = input disconnected or connected driver off



LOGIC DIAGRAM (POSITIVE LOGIC) 9 DOUT1 14 DIN1 -DIN2 \_\_\_\_\_13 10 DOUT2 DIN3 \_\_\_\_\_ 11 DOUT3 22 FORCEOFF 21 INVALID Auto-powerdown 23 FORCEON -ROUT1 \_\_\_\_\_ 4 RIN1 20 ROUT2B -ROUT2 \_\_\_\_\_\_ 5 RIN2 6 RIN3 ROUT3 \_\_\_\_\_ 7 RIN4 ROUT4 \_\_\_\_\_ ROUT5 \_\_\_\_\_ 8 RIN5

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NSTRUMENTS

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### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range <sup>(2)</sup>		-0.3	6	V
V+	Positive output supply voltage range <sup>(2)</sup>		-0.3	7	V
V–	Negative output supply voltage range <sup>(2)</sup>		0.3	-7	V
V+ - V-	Output supply voltage difference <sup>(2)</sup>			13	V
V		Driver (FORCEOFF, FORCEON)	-0.3	6	V
VI	Input voltage range	Receiver	-25	6 7 7 13	V
		Driver	-13.2	13.2	V
Vo	Output voltage range	Receiver (INVALID)	-0.3	$ \begin{array}{r} 6 \\ 7 \\ -7 \\ 13 \\ 6 \\ 25 \\ 13.2 \\ V_{CC} + 0.3 \\ 62 \\ 46 \\ 62 \\ 260 \\ \end{array} $	V
		DB package		62	
$\theta_{JA}$	Package thermal impedance <sup>(3)(4)</sup>	DW package		46	C/W
		PW package		$ \begin{array}{r} 6 \\ 7 \\ -7 \\ 13 \\ 6 \\ 25 \\ 13.2 \\ V_{CC} + 0.3 \\ 62 \\ 46 \\ 62 \\ 260 \\ \end{array} $	
	Lead temperature 1,6 mm (1/16 in) from ca	se for 10 s		260	С
T <sub>stg</sub>	Storage temperature range		-65	150	С

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

All voltages are with respect to network GND. (2)

Maximum power dissipation is a function of  $T_J(max)$ ,  $\theta_{JA}$ , and  $T_A$ . The maximum allowable power dissipation at any allowable ambient (3) temperature is  $P_D = (T_J(max) - T_A)/\theta_{JA}$ . Operating at the absolute maximum  $T_J$  of 150°C can affect reliability. The package thermal impedance is calculated in accordance with JESD 51-7.

(4)

## **RECOMMENDED OPERATING CONDITIONS**<sup>(1)</sup>

#### See Figure 6

				MIN	NOM	MAX	UNIT
	Supply voltage		$V_{CC} = 3.3 V$	3	3.3	3.6	v
	Supply voltage		$V_{CC} = 5 V$	4.5	3     3.3     3.6       4.5     5     5.5       2	v	
v	H Driver and control high-level input voltage		$V_{CC} = 3.3 V$	2			v
VIH		DIN, FORCEOFF, FORCEON	$V_{CC} = 5 V$	2.4			V
$V_{\text{IL}}$	Driver and control low-level input voltage	DIN, FORCEOFF, FORCEON				0.8	V
VI	Driver and control input voltage	DIN, FORCEOFF, FORCEON		0		5.5	V
VI	Receiver input voltage			-25		25	V
т	Operating free air temperature		MAX3243EC	0		70	<u> </u>
T <sub>A</sub>	Operating free-air temperature		MAX3243EI	-40		85	С

(1) Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V.

## ELECTRICAL CHARACTERISTICS<sup>(1)</sup>

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 6)

	PAR	AMETER	TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
$I_{I}$	Input leakage current	FORCEOFF, FORCEON			0.01	1	μΑ
		Auto-powerdown disabled	No load, FORCEOFF and FORCEON at $V_{CC}$		0.3	1	mA
	Supply current	Powered off	No load, FORCEOFF at GND	t V <sub>CC</sub> 1	10		
Icc	Supply current (T <sub>A</sub> = 25°C)	Auto-powerdown enabled	No load, $\overline{\text{FORCEOFF}}$ at V <sub>CC</sub> , FORCEON at GND, All RIN are open or grounded, All DIN are grounded		1	10	μΑ

Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V. All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C. (1)

(2)

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## **DRIVER SECTION**

## Electrical Characteristics<sup>(1)</sup>

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 6)

	PARAMETER	TES	ST CONDITIONS	i i i i i i i i i i i i i i i i i i i	MIN	TYP <sup>(2)</sup>	MAX	UNIT
$V_{OH}$	High-level output voltage	All DOUT at $R_L = 3 k\Omega$ to 0	GND		5	5.4		V
V <sub>OL</sub>	Low-level output voltage	All DOUT at $R_L = 3 k\Omega$ to 0	GND		-5	-5.4		V
Vo	Output voltage (mouse driveability)	DIN1 = DIN2 = GND, DIN3 DOUT1 = DOUT2 = 2.5 m/		GND at DOUT3,	±5			V
I <sub>IH</sub>	High-level input current	$V_I = V_{CC}$				±0.01	±1	μA
$I_{IL}$	Low-level input current	V <sub>I</sub> at GND				±0.01	±1	μA
V <sub>hys</sub>	Input hysteresis						±1	V
	Short-circuit output current <sup>(3)</sup>	V <sub>CC</sub> = 3.6 V,	$V_{O} = 0 V$				±60	mA
I <sub>OS</sub>		V <sub>CC</sub> = 5.5 V,	$V_{O} = 0 V$				±00	ША
r <sub>o</sub>	Output resistance	$V_{CC}$ , V+, and V– = 0 V,	$V_0 = \pm 2 V$		300	10M		Ω
I <sub>off</sub>	Output leakage current	$\overline{FORCEOFF} = GND,$	$V_0 = \pm 12 V$ ,	$V_{CC}$ = 0 to 5.5 V			±25	μA

(1)

(2)

Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V. All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C. Short-circuit durations should be controlled to prevent exceeding the device absolute power dissipation ratings, and not more than one (3) output should be shorted at a time.

## Switching Characteristics<sup>(1)</sup>

switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 6)

	PARAMETER	TEST C	ONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
	Maximum data rate	C <sub>L</sub> = 1000 pF, One DOUT switching,	R <sub>L</sub> = 3 kΩ See Figure 1	250	500		kbit/s
t <sub>sk(p)</sub>	Pulse skew <sup>(3)</sup>	$C_{L} = 150 \text{ pF} \text{ to } 2500 \text{ pF},$	$R_L = 3 \ k\Omega$ to 7 k $\Omega$ , See Figure 2		100		ns
	Slew rate, transition region	V <sub>CC</sub> = 3.3 V,	$C_{L} = 150 \text{ pF}$ to 1000 pF	6		30	
SR(tr)	(see Figure 1)	$R_L = 3 k\Omega$ to 7 kΩ, PRR = 250 kbit/s	C <sub>L</sub> = 150 pF to 2500 pF	4		30	V/µs

Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V + 0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V. All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C. Pulse skew is defined as |t<sub>PLH</sub> - t<sub>PHL</sub>| of each channel of the same device. (1)

(2)

(3)

## **ESD** Protection

PARAMETER	TEST CONDITIONS	TYP	UNIT
	НВМ	TYP           ±15           ±15           ±8	kV
Driver outputs (pins 9–11)	HBM ±15 IEC61000-4-2, Air-Gap Discharge ±15	±15	kV
		±8	kV

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## **RECEIVER SECTION**

## Electrical Characteristics<sup>(1)</sup>

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 6)

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	$I_{OH} = -1 \text{ mA}$	$V_{CC} - 0.6$	V <sub>CC</sub> – 0.1		V
V <sub>OL</sub>	Low-level output voltage	I <sub>OH</sub> = 1.6 mA			0.4	V
V	Positive-going input threshold voltage	$V_{CC} = 3.3 V$		1.6	2.4	V
V <sub>IT+</sub>	Positive-going input theshold voltage	$V_{CC} = 5 V$		1.9	2.4	v
V	Negative going input threaded values	V <sub>CC</sub> = 3.3 V	0.6	1.1		V
V <sub>IT-</sub>	Negative-going input threshold voltage	$V_{CC} = 5 V$	0.8	1.4		v
V <sub>hys</sub>	Input hysteresis (V <sub>IT+</sub> – V <sub>IT-</sub> )			0.5		V
I <sub>off</sub>	Output leakage current (except ROUT2B)	FORCEOFF = 0 V		±0.05	±10	μA
r <sub>i</sub>	Input resistance	$V_1 = \pm 3 \text{ V or } \pm 25 \text{ V}$	3	5	7	kΩ

Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V. All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C. (1)

(2)

## Switching Characteristics<sup>(1)</sup>

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	TYP <sup>(2)</sup>	UNIT
t <sub>PLH</sub>	Propagation delay time, low- to high-level output	$C_L = 150 \text{ pF}$ , See Figure 3	150	ns
t <sub>PHL</sub>	Propagation delay time, high- to low-level output		150	ns
t <sub>en</sub>	Output enable time	$C_L = 150 \text{ pF}, R_L = 3 \text{ k}\Omega$ , See Figure 4	200	ns
t <sub>dis</sub>	Output disable time		200	ns
t <sub>sk(p)</sub>	Puse skew <sup>(3)</sup>	See Figure 3	50	ns

Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V  $\pm$  0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V. All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C. Pulse skew is defined as |t<sub>PLH</sub> - t<sub>PHL</sub>| of each channel of the same device. (1)

(2)

(3)

## **ESD** Protection

PARAMETER	TEST CONDITIONS	TYP	UNIT
	НВМ	±15	kV
Driver outputs (pins 4–8)	IEC61000-4-2, Air-Gap discharge	±15	kV
	IEC61000-4-2, Contact Discharge	±8	kV

## AUTO-POWERDOWN SECTION

### **Electrical Characteristics**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5)

	PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT
V <sub>IT+(valid)</sub>	Receiver input threshold for INVALID high-level output voltage	FORCEON = GND, FORCEOFF = V <sub>CC</sub>		2.7	V
V <sub>IT-(valid)</sub>	Receiver input threshold for INVALID high-level output voltage	$\frac{\text{FORCEON} = \text{GND},}{\text{FORCEOFF} = V_{CC}}$	-2.7		V
V <sub>T(invalid)</sub>	Receiver input threshold for INVALID low-level output voltage	$\frac{\text{FORCEON} = \text{GND},}{\text{FORCEOFF} = V_{CC}}$	-0.3	0.3	V
V <sub>OH</sub>	INVALID high-level output voltage	$I_{OH} = -1 \text{ mA}$ , FORCEON = GND, FORCEOFF = V <sub>CC</sub>	V <sub>CC</sub> – 0.6		V
V <sub>OL</sub>	INVALID low-level output voltage	$I_{OL}$ = 1.6 mA, FORCEON = GND, FORCEOFF = V <sub>CC</sub>		0.4	V

## **Switching Characteristics**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5)

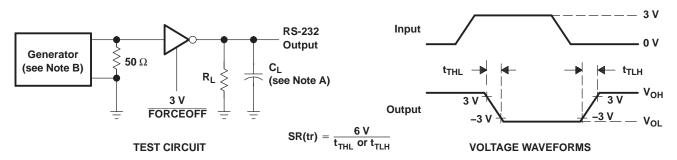
	PARAMETER	TEST CONDITIONS	TYP <sup>(1)</sup>	UNIT
t <sub>valid</sub>	Propagation delay time, low- to high-level output	$V_{CC} = 5 V$	1	μs
t <sub>invalid</sub>	Propagation delay time, high- to low-level output	$V_{CC} = 5 V$	30	μs
t <sub>en</sub>	Supply enable time	$V_{CC} = 5 V$	100	μs

(1) All typical values are at V\_{CC} = 3.3 V or V\_{CC} = 5 V, and T\_A = 25 ^{\circ}C.



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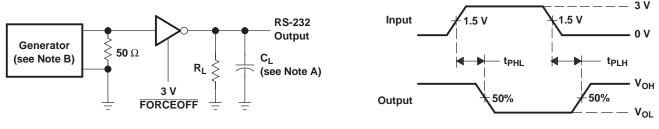
## PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

B. The pulse generator has the following characteristics:  $Z_0 = 50 \Omega$ , 50% duty cycle,  $t_r \le 10$  ns,  $t_f \le 10$  ns.

#### Figure 1. Driver Slew Rate



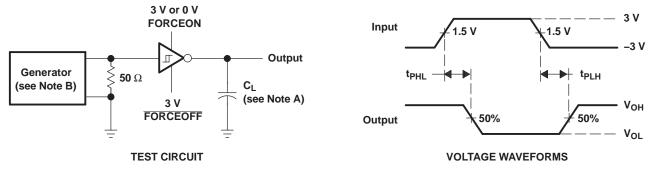
#### **TEST CIRCUIT**

VOLTAGE WAVEFORMS

NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 250 kbit/s,  $Z_0 = 50 \Omega$ , 50% duty cycle,  $t_r \le 10$  ns,  $t_f \le 10$  ns.

Figure 2. Driver Pulse Skew



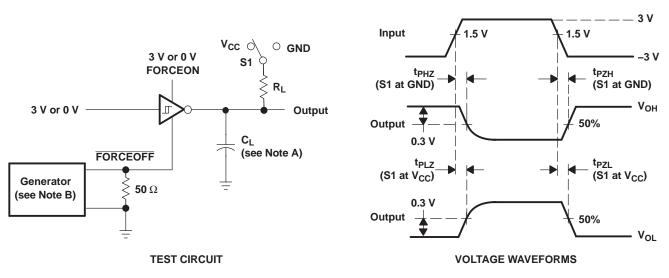
NOTES: A. C<sub>L</sub> includes probe and jig capacitance. B. The pulse generator has the following characteristics:  $Z_O = 50 \Omega$ , 50% duty cycle,  $t_f \le 10$  ns,  $t_f \le 10$  ns.

#### Figure 3. Receiver Propagation Delay Times

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## PARAMETER MEASUREMENT INFORMATION

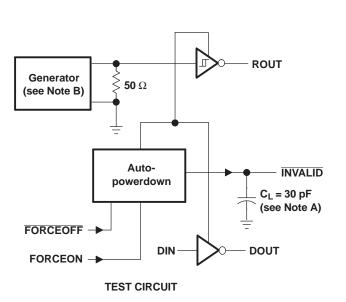
NOTES: A.  $C_{\text{L}}$  includes probe and jig capacitance.

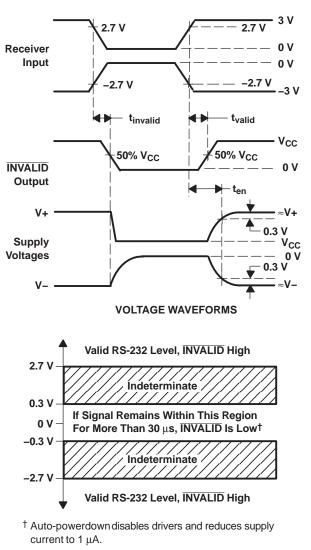
- B. The pulse generator has the following characteristics:  $Z_0$  = 50  $\Omega$ , 50% duty cycle,  $t_r \le 10$  ns.  $t_f \le 10$  ns.
- C.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- D.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .

#### Figure 4. Receiver Enable and Disable Times



### PARAMETER MEASUREMENT INFORMATION





NOTES: A.  $C_L$  includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 5 kbit/s,  $Z_{O}$  = 50  $\Omega$ , 50% duty cycle,  $t_{f} \le 10$  ns.  $t_{f} \le 10$  ns.

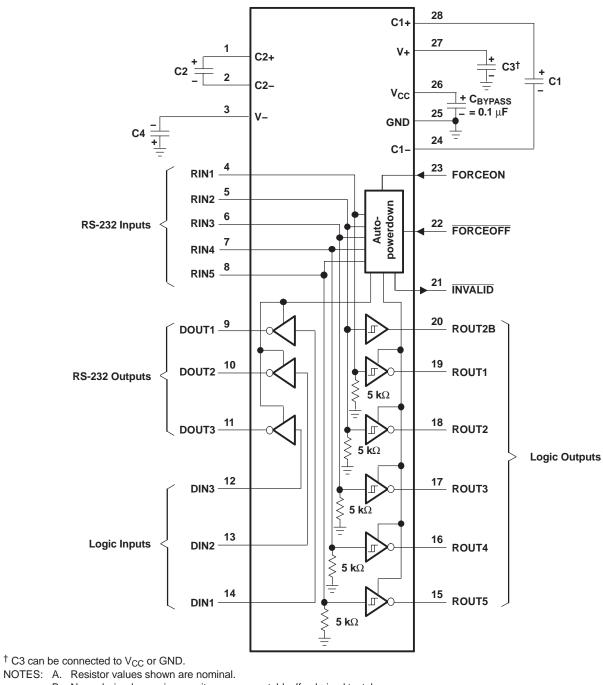
#### Figure 5. INVALID Propagation Delay Timnes and Supply Enabling Time

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 B. Nonpolarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

#### V<sub>CC</sub> vs CAPACITOR VALUES

V <sub>CC</sub>	C1	C2, C3, and C4
$\begin{array}{c} \textbf{3.3 V} \pm \textbf{0.3 V} \\ \textbf{5 V} \pm \textbf{0.5 V} \\ \textbf{3 V to 5.5 V} \end{array}$	0.1 μF 0.047 μF 0.1 μF	0.1 μF 0.33 μF 0.47 μF

Figure 6. Typical Operating Circuit and Capacitor Values



SLLS657C-APRIL 2005-REVISED FEBRUARY 2009

## **APPLICATION INFORMATION**

### **ESD** Protection

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TI MAX3243E devices have standard ESD protection structures incorporated on the pins to protect against electrostatic discharges encountered during assembly and handling. In addition, the RS232 bus pins (driver outputs and receiver inputs) of these devices have an extra level of ESD protection. Advanced ESD structures were designed to successfully protect these bus pins against ESD discharge of ±15-kV in all states: normal operation, shutdown, and powered down. The MAX3243E devices are designed to continue functioning properly after an ESD occurrence without any latchup.

The MAX3243E devices have three specified ESD limits on the driver outputs and receiver inputs, with respect to GND:

- ±15-kV Human Body Model (HBM)
- ±15-kV IEC61000-4-2, Air-Gap Discharge (formerly IEC1000-4-2)
- ±8-kV IEC61000-4-2, Contact Discharge

#### **ESD Test Conditions**

ESD testing is stringently performed by TI, based on various conditions and procedures. Please contact TI for a reliability report that documents test setup, methodology, and results.

### Human Body Model (HBM)

The Human Body Model of ESD testing is shown in Figure 7, while Figure 8 shows the current waveform that is generated during a discharge into a low impedance. The model consists of a 100-pF capacitor, charged to the ESD voltage of concern, and subsequently discharged into the DUT through a 1.5k- $\Omega$  resistor.

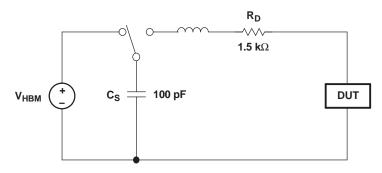


Figure 7. HBM ESD Test Circuit

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**APPLICATION INFORMATION** 

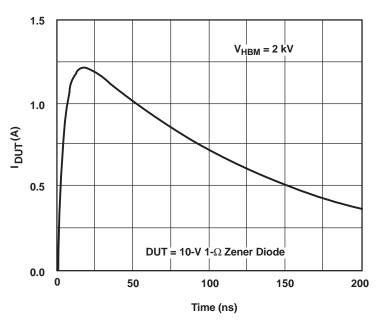


Figure 8. Typical HBM Current Waveform

## IEC61000-4-2 (Formerly Known as IEC1000-4-2)

Unlike the HBM, MM, and CDM ESD tests that apply to component level integrated circuits, the IEC61000-4-2 is a system-level ESD testing and performance standard that pertains to the end equipment. The MAX3243E is designed to enable the manufacturer in meeting the highest level (Level 4) of IEC61000-4-2 ESD protection with no further need of external ESD protection circuitry. The more stringent IEC test standard has a higher peak current than the HBM, due to the lower series resistance in the IEC model.

Figure 9 shows the IEC61000-4-2 model, and Figure 10 shows the current waveform for the corresponding  $\pm$ 8-kV Contact-Discharge (Level 4) test. This waveform is applied to a probe that has been connected to the DUT. On the other hand, the corresponding  $\pm$ 15-kV (Level 4) Air-Gap Discharge test involves approaching the DUT with an already energized probe.

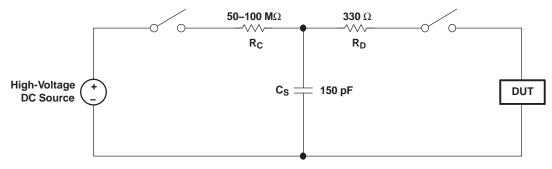
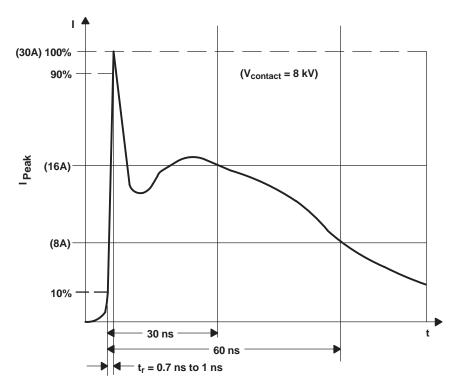


Figure 9. Simplified IEC61000-4-2 ESD Test Circuit

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**APPLICATION INFORMATION** 

#### Figure 10. Typical Current Waveform of IEC61000-4-2 ESD Generator

#### Machine Model

The Machine Model (MM) ESD test applies to all pins using a 200-pF capacitor with no discharge resistance. The purpose of the MM test is to simulate possible ESD conditions that can occur during the handling and assembly processes of manufacturing. In this case, ESD protection is required for all pins, not just RS-232 pins. However, after PC board assembly, the MM test is no longer as pertinent to the RS-232 pins.

16-Apr-2009

## **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
MAX3243ECDB	ACTIVE	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECDBE4	ACTIVE	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECDBG4	ACTIVE	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECDBR	ACTIVE	SSOP	DB	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECDBRE4	ACTIVE	SSOP	DB	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECDBRG4	ACTIVE	SSOP	DB	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECDW	ACTIVE	SOIC	DW	28	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECDWG4	ACTIVE	SOIC	DW	28	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECDWR	ACTIVE	SOIC	DW	28	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECDWRG4	ACTIVE	SOIC	DW	28	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECPW	ACTIVE	TSSOP	PW	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECPWE4	ACTIVE	TSSOP	PW	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECPWG4	ACTIVE	TSSOP	PW	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECPWR	ACTIVE	TSSOP	PW	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECPWRE4	ACTIVE	TSSOP	PW	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECPWRG4	ACTIVE	TSSOP	PW	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243ECRHBR	ACTIVE	QFN	RHB	32	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
MAX3243ECRHBRG4	ACTIVE	QFN	RHB	32	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
MAX3243EIDB	ACTIVE	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243EIDBG4	ACTIVE	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243EIDBR	ACTIVE	SSOP	DB	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243EIDBRG4	ACTIVE	SSOP	DB	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243EIDW	ACTIVE	SOIC	DW	28	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243EIDWG4	ACTIVE	SOIC	DW	28	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243EIDWR	ACTIVE	SOIC	DW	28	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

RUMENTS

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
MAX3243EIDWRG4	ACTIVE	SOIC	DW	28	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243EIPW	ACTIVE	TSSOP	PW	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243EIPWE4	ACTIVE	TSSOP	PW	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243EIPWG4	ACTIVE	TSSOP	PW	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243EIPWR	ACTIVE	TSSOP	PW	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243EIPWRE4	ACTIVE	TSSOP	PW	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243EIPWRG4	ACTIVE	TSSOP	PW	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX3243EIRHBR	ACTIVE	QFN	RHB	32	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
MAX3243EIRHBRG4	ACTIVE	QFN	RHB	32	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. **TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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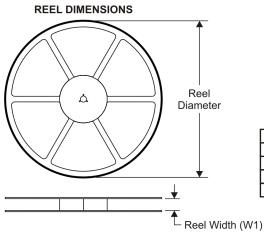
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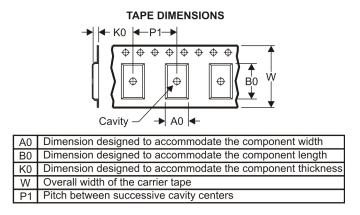
# PACKAGE MATERIALS INFORMATION

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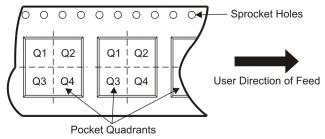
Texas Instruments

## TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
MAX3243ECDBR	SSOP	DB	28	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
MAX3243ECDWR	SOIC	DW	28	1000	330.0	32.4	11.35	18.67	3.1	16.0	32.0	Q1
MAX3243ECPWR	TSSOP	PW	28	2000	330.0	16.4	7.1	10.4	1.6	12.0	16.0	Q1
MAX3243ECRHBR	QFN	RHB	32	3000	330.0	12.4	5.3	5.3	1.5	8.0	12.0	Q2
MAX3243EIDBR	SSOP	DB	28	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
MAX3243EIDWR	SOIC	DW	28	1000	330.0	32.4	11.35	18.67	3.1	16.0	32.0	Q1
MAX3243EIPWR	TSSOP	PW	28	2000	330.0	16.4	6.9	10.2	1.8	12.0	16.0	Q1
MAX3243EIPWR	TSSOP	PW	28	2000	330.0	16.4	7.1	10.4	1.6	12.0	16.0	Q1
MAX3243EIRHBR	QFN	RHB	32	3000	330.0	12.4	5.3	5.3	1.5	8.0	12.0	Q2

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# PACKAGE MATERIALS INFORMATION

1-Nov-2010



*All dimensions are nominal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
MAX3243ECDBR	SSOP	DB	28	2000	346.0	346.0	33.0
MAX3243ECDWR	SOIC	DW	28	1000	346.0	346.0	49.0
MAX3243ECPWR	TSSOP	PW	28	2000	346.0	346.0	33.0
MAX3243ECRHBR	QFN	RHB	32	3000	346.0	346.0	29.0
MAX3243EIDBR	SSOP	DB	28	2000	346.0	346.0	33.0
MAX3243EIDWR	SOIC	DW	28	1000	346.0	346.0	49.0
MAX3243EIPWR	TSSOP	PW	28	2000	346.0	346.0	33.0
MAX3243EIPWR	TSSOP	PW	28	2000	346.0	346.0	33.0
MAX3243EIRHBR	QFN	RHB	32	3000	346.0	346.0	29.0

DW (R-PDSO-G28)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AE.



PW (R-PDSO-G28)

PLASTIC SMALL OUTLINE



NOTES:

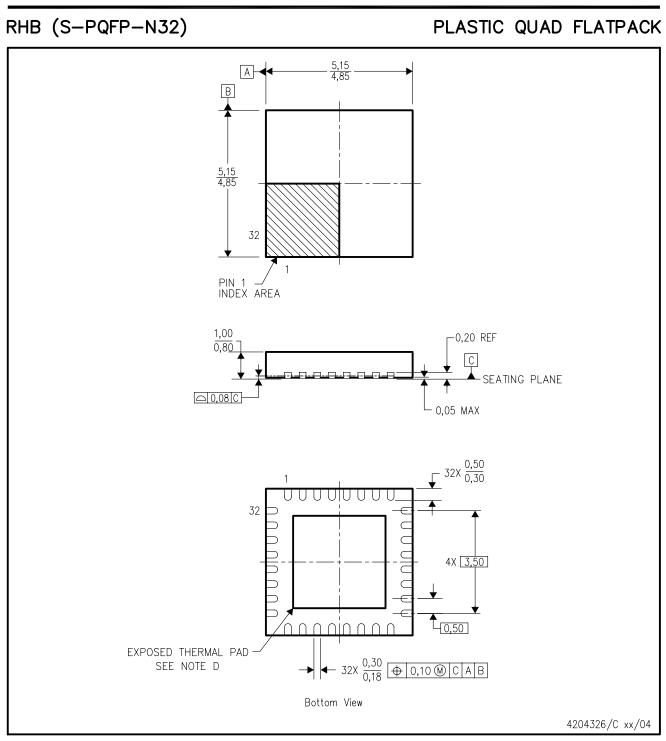
A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 B. This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) Package configuration.
- D The Package thermal pad must be soldered to the board for thermal and mechanical performance.
- See product data sheet for details regarding the exposed thermal pad dimensions.
- E. Falls within JEDEC MO-220.



## RHB (S-PVQFN-N32)

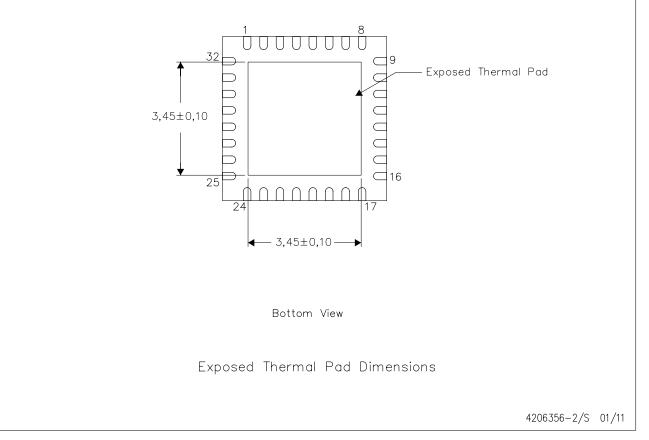
## PLASTIC QUAD FLATPACK NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.

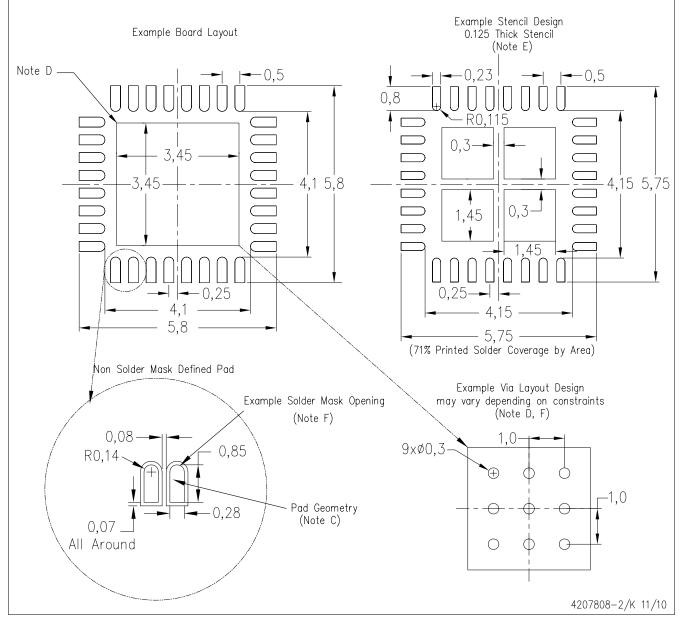


#### NOTE: A. All linear dimensions are in millimeters



# RHB (S-PVQFN-N32)

# PLASTIC QUAD FLATPACK NO-LEAD



NOTES: A.

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="http://www.ti.com">http://www.ti.com</a>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting recommendations for vias placed in the thermal pad.



# **MECHANICAL DATA**

MSSO002E - JANUARY 1995 - REVISED DECEMBER 2001

## DB (R-PDSO-G\*\*)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



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Power Mgmt	power.ti.com	Transportation and Automotive	www.ti.com/automotive
Microcontrollers	microcontroller.ti.com	Video and Imaging	www.ti.com/video
RFID	www.ti-rfid.com	Wireless	www.ti.com/wireless-apps
RF/IF and ZigBee® Solutions	www.ti.com/lprf		

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